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Substitute Form PTO-1449 (Modified)		U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 14083-002001	Application No. 10/016,475
Information Disclosure Statement by Applicant (Use several sheets if necessary)		Applicant Roger Proksch et al.		
(37 CFR §1.98(b))		Filing Date November 30, 2001	Group Art Unit 2862	

U.S. Patent Documents

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
NP	AA	2 364 237	Dec 5, 1944	Neff			
	AB	2 452 862	Nov 2, 1948	Neff			
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	AD	4 030 085	June 14, 1977	Ellis et al.			
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	AG	4 705 971	Nov 10, 1987	Nagasaki			
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	AI	5 461 319	Oct 24, 1995	Peters			
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	AR	5 948 972	Sep 7 1999	Samsavar et al.			
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	AT						

Foreign Patent Documents or Published Foreign Patent Applications

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AU							
	AV							
	AW							
	AX							

Examiner Signature <i>J. Proksch</i>	Date Considered 6/10/03
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

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Sheet 2 of 2

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Foreign Patent Documents or Published Foreign Patent Applications

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation Yes <input checked="" type="checkbox"/> No <input type="checkbox"/>
	AY						

Other Documents (include Author, Title, Date, and Place of Publication)

Examiner Initial	Desig. ID	Document
<i>JRP</i>	AZ	Bertram, H.N. <i>Theory of Magnetic Recording</i> . Cambridge, England: Cambridge University Press, 1994. 112-119.
	AAA	Bozorth, R. M. <i>Ferromagnetism</i> . Princeton, NJ: Van Nostrand, 1951. 524-532
	ABB	Crommie, M.F., C.P. Lutz and D.M. Eigler. "Confinement of Electrons to Quantum Corrals on a Metal Surface." <i>Science</i> 262 (8 October 1993): 218-220.
	ACC	Drexler, K Eric. "Molecular directions in nanotechnology." <i>Nanotechnology</i> 2 (1991): 113-118.
	ADD	Hristoforou, E., H. Chiriac, and Maria Neagu. "A Low Core Mass Linear Variable Differential Transformers Sensor Using Amorphous Wires." <i>Romanian Journal of Physics</i> 41.9-10 (1996): 765-769
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	AFF	Meydan, T. and G.W. Healey. "Linear variable differential transformer (LVDT): linear displacement transducer utilizing ferromagnetic amorphous metallic glass ribbons." <i>Sensors and Actuators A: Physical</i> 32.1-3 (April 1992): 582-587.
	AGG	Midgley, G.W., D. Howe, and P.H. Mellor. "Improved Linearity Linear Variable Differential Transformers (LVDTs) Through the Use of Alternative Magnetic Materials." <i>Electric and Magnetic Fields: From Numerical Models to Industrial Applications</i> . Ed. André Nicolet and R. Belmans. New York: Plenum Press, 1995. 311-314.
	AHH	Park, Young Tae, Han Jun Kim, Kwang Min Yu, and Rae Duk Lee. "Study on a Linear Variable Differential Transformer for Precision Measurements." <i>Korean Applied Physics</i> 2.4 (November 1989): 347-351.
	AII	Piner, Richard D., Jin Zhu, Feng Xu, Seunghun Hong, and Chad A. Mirkin. " 'Dip-Pen' Nanolithography." <i>Science</i> 283 (29 January 1999): 661-663
<i>JRP</i>	AJJ	Saxena, Suresh C. and S.B. Lal Seksen. "A Self-Compensated Smart LVDT Transducer." <i>IEEE Transactions on Instrumentation and Measurement</i> 38.3 (June 1989): 748-753.

Examiner Signature <i>JRP</i>	Date Considered 6/20/03
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